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TISP61089D, TISP61089SD, TISP61089AD,  
TISP61089ASD

DUAL FORWARD-CONDUCTING P-GATE THYRISTORS  
PROGRAMMABLE OVERVOLTAGE PROTECTORS

**TISP61089 Gated Protector Series**

Overvoltage Protection for Negative Rail SLICs

Dual Voltage-Tracking Protectors

- '61089 for Battery Voltages to ..... -75 V
- '61089A for Battery Voltages to ..... -100 V
- Low Gate Triggering Current ..... < 5 mA
- High Holding Current ..... > 150 mA

Rated for GR-1089-CORE and K.44 Impulses

Impulse Wave Shape		I <sub>PPSM</sub> A
Voltage	Current	
2/10	2/10	120
10/700	5/310	40
10/1000	10/1000	30

2/10 Overshoot Voltage Specified

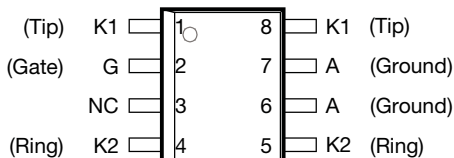
Element	I <sub>pp</sub> = 100 A, 2/10
	V
Diode	8
SCR	12

Package Options

- Surface Mount 8-pin Small-Outline
- Line Feed-Thru Connection (D)
- Shunt Version Connection (SD)

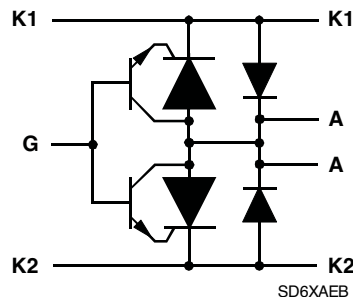
..... UL Recognized Components

**D Package Top View and Device Symbol for Feed-Thru Pin-Out**



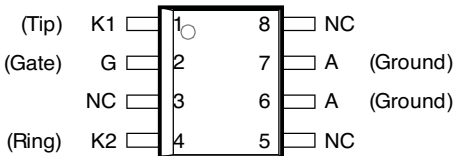
NC - No internal connection  
Terminal typical application names shown in parenthesis

MD6XBDA



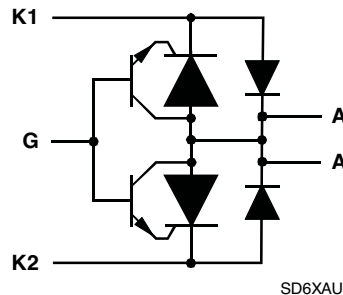
SD6XAEB

**D Package Top View and Device Symbol for Shunt (SD) Pin-Out**



NC - No internal connection  
Terminal typical application names shown in parenthesis

MD6XBE



SD6XAU

**How To Order**

Device	Package	Carrier	Order As	Device	Package	Carrier	Order As
TISP61089	D (Small-Outline)	R†	TISP61089DR-S	TISP61089A	D (Small-Outline)	R†	TISP61089ADR-S
TISP61089S	D (Small-Outline)	R†	TISP61089SDR-S	TISP61089AS	D (Small-Outline)	R†	TISP61089ASDR-S
† Carrier R is Embossed Tape Reeled				† Carrier R is Embossed Tape Reeled			

\*RoHS Directive 2002/95/EC Jan 27 2003 including Annex  
NOVEMBER 1995 - REVISED JULY 2008  
Specifications are subject to change without notice.  
Customers should verify actual device performance in their specific applications.

# TISP61089 Gated Protector Series

**BOURNS®**

## Description

These '61089 parts are all dual forward-conducting buffered p-gate thyristor (SCR) overvoltage protectors. They are designed to protect monolithic SLICs (Subscriber Line Interface Circuits) against overvoltages on the telephone line caused by lightning, a.c. power contact and induction. The '61089 limits voltages that exceed the SLIC supply rail voltage. The '61089 parameters are specified to allow equipment compliance with Telcordia (formally Bellcore) GR-1089-CORE and ITU-T recommendations K.20, K.21 and K.45.

The SLIC line driver section is typically powered from 0 V (ground) and a negative (battery) voltage. The protector gate is connected to this negative supply. This references the protection (clipping) voltage to the negative supply voltage. The protection voltage will then track the negative supply voltage and the overvoltage stress on the SLIC is minimized.

Positive overvoltages are clipped to ground by diode forward conduction. Negative overvoltages are initially clipped close to the SLIC negative supply rail value. If sufficient current is available from the overvoltage, then the protector SCR will switch into a low voltage on-state condition. As the overvoltage subsides the high holding current of '61089 SCR helps prevent d.c. latchup.

The '61089 is intended to be used with a series resistance of at least 25  $\Omega$  and a suitable overcurrent function for Telcordia compliance. Power fault conditions require a series overcurrent element which either interrupts or reduces the circuit current before the '61089 current rating is exceeded. For equipment compliant to ITU-T recommendations K.20 or K.21 or K.45 only, the series resistor value is set by the coordination requirements. For coordination with a 400 V limit GDT, a minimum series resistor value of 10  $\Omega$  is recommended.

The '61089 buffered gate design reduces the loading on the SLIC supply during overvoltages caused by power cross and induction. The regular pin-out for surface mount and through-hole packages is a feed through configuration. Connection to the SLIC is made via the '61089, Ring through pins 4 - 5 and Tip through pins 1 - 8. A non-feed-through surface mount (D) package is available. This shunt (SD) version pin-out does not make duplicate connections to pin 5 and pin 8 which increases package creepage distance from ground of the other connections from about 0.7 mm to over 3 mm. High voltage ringing SLICs, with battery voltages below -100 V and down to -155 V, can be protected by the TISP61089B device. Details of this device are in the TISP61089B data sheet.

## Absolute Maximum Ratings, $-40\text{ }^{\circ}\text{C} \leq T_J \leq 85\text{ }^{\circ}\text{C}$ (Unless Otherwise Noted)

Rating	Symbol	Value	Unit
61089 '61089A Repetitive peak off-state voltage, $V_{GK} = 0$	$V_{DRM}$	-100 -120	V
61089 '61089A Repetitive peak gate-cathode voltage, $V_{KA} = 0$	$V_{GKRM}$	-85 -120	V
Non-repetitive peak on-state pulse current (see Notes 1 and 2) 10/1000 $\mu\text{s}$ (Telcordia (Bellcore) GR-1089-CORE, Issue 2, February 1999, Section 4) 5/320 $\mu\text{s}$ (ITU-T K.20, K.21 & K.45, K.44 open-circuit voltage wave shape 10/700 $\mu\text{s}$ ) 1.2/50 $\mu\text{s}$ (Telcordia (Bellcore) GR-1089-CORE, Issue 2, February 1999, Section 4) 2/10 $\mu\text{s}$ (Telcordia (Bellcore) GR-1089-CORE, Issue 2, February 1999, Section 4)	$I_{PPSM}$	30 40 100 120	A
Non-repetitive peak on-state current, $V_{GG} = -75\text{ V}$ , 50 Hz to 60 Hz (see Notes 1 and 2) 0.1 s 1 s 5 s 300 s 900 s	$I_{TSM}$	11 4.8 2.7 0.95 0.93	A
Non-repetitive peak gate current, 1/2 $\mu\text{s}$ pulse, cathodes commoned (see Notes 1 and 2)	$I_{GSM}$	+40	A
Operating free-air temperature range	$T_A$	-40 to +85	$^{\circ}\text{C}$
Junction temperature	$T_J$	-40 to +150	$^{\circ}\text{C}$
Storage temperature range	$T_{stg}$	-40 to +150	$^{\circ}\text{C}$

NOTES: 1. Initially the protector must be in thermal equilibrium with  $-40\text{ }^{\circ}\text{C} \leq T_J \leq 85\text{ }^{\circ}\text{C}$ . The surge may be repeated after the device returns to its initial conditions. Gate voltage ranges are -20 V to -75 V for the '61089 and -20 V to -100 V for the '61089A.

2. The rated current values may be applied either to the Ring to Ground or to the Tip to Ground terminal pairs. Additionally, both terminal pairs may have their rated current values applied simultaneously (in this case the Ground terminal current will be twice the rated current value of an individual terminal pair). Above 85  $^{\circ}\text{C}$ , derate linearly to zero at 150  $^{\circ}\text{C}$  lead temperature.

# TISP61089 Gated Protector Series

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## Recommended Operating Conditions

Component		Min	Typ	Max	Unit
C <sub>G</sub>	Gate decoupling capacitor	100	220		nF
R <sub>S</sub>	Series resistor for GR-1089-CORE first-level surge survival	25			Ω
	Series resistor for GR-1089-CORE first-level and second-level surge survival	40			Ω
	Series resistor for GR-1089-CORE intra-building port surge survival	8			Ω
	Series resistor for K.20, K.21 and K.45 coordination with a 400 V primary protector	10			Ω

## Electrical Characteristics, T<sub>J</sub> = 25 °C (Unless Otherwise Noted)

Parameter	Test Conditions	Min	Typ	Max	Unit	
I <sub>D</sub> Off-state current	V <sub>D</sub> = V <sub>DRM</sub> , V <sub>GK</sub> = 0			T <sub>J</sub> = 25 °C	-5	μA
				T <sub>J</sub> = 85 °C	-50	μA
V <sub>(BO)</sub> Breakover voltage	2/10 μs, I <sub>PP</sub> = -56 A, R <sub>S</sub> = 45 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		-57		V	
	2/10 μs, I <sub>PP</sub> = -100 A, R <sub>S</sub> = 50 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		-60			
	1.2/50 μs, I <sub>PP</sub> = -53 A, R <sub>S</sub> = 47 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		-60			
	1.2/50 μs, I <sub>PP</sub> = -96 A, R <sub>S</sub> = 52 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		-64			
V <sub>GK(BO)</sub> Gate-cathode impulse breakover voltage	2/10 μs, I <sub>PP</sub> = -56 A, R <sub>S</sub> = 45 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		9		V	
	2/10 μs, I <sub>PP</sub> = -100 A, R <sub>S</sub> = 50 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		12			
	1.2/50 μs, I <sub>PP</sub> = -53 A, R <sub>S</sub> = 47 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		12			
	1.2/50 μs, I <sub>PP</sub> = -96 A, R <sub>S</sub> = 52 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		16			
V <sub>F</sub> Forward voltage	I <sub>F</sub> = 5 A, t <sub>w</sub> = 200 μs			3	V	
V <sub>FRM</sub> Peak forward recovery voltage	2/10 μs, I <sub>PP</sub> = 56 A, R <sub>S</sub> = 45 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		6		V	
	2/10 μs, I <sub>PP</sub> = 100 A, R <sub>S</sub> = 50 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		8			
	1.2/50 μs, I <sub>PP</sub> = 53 A, R <sub>S</sub> = 47 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		8			
	1.2/50 μs, I <sub>PP</sub> = 96 A, R <sub>S</sub> = 52 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		12			
I <sub>H</sub> Holding current	I <sub>T</sub> = -1 A, di/dt = 1 A/ms, V <sub>GG</sub> = -48 V	-150			mA	
I <sub>GKS</sub> Gate reverse current	V <sub>GG</sub> = V <sub>GK</sub> = V <sub>GKRM</sub> , V <sub>KA</sub> = 0			T <sub>J</sub> = 25 °C	-5	μA
				T <sub>J</sub> = 85 °C	-50	μA
I <sub>GT</sub> Gate trigger current	I <sub>T</sub> = -3 A, t <sub>p(g)</sub> ≥ 20 μs, V <sub>GG</sub> = -48 V			5	mA	
V <sub>GT</sub> Gate-cathode trigger voltage	I <sub>T</sub> = -3 A, t <sub>p(g)</sub> ≥ 20 μs, V <sub>GG</sub> = -48 V			2.5	V	
Q <sub>GS</sub> Gate switching charge	1.2/50 μs, I <sub>PP</sub> = -53 A, R <sub>S</sub> = 47 Ω, V <sub>GG</sub> = -48 V, C <sub>G</sub> = 220 nF		0.1		μC	
C <sub>KA</sub> Cathode-anode off-state capacitance	f = 1 MHz, V <sub>d</sub> = 1 V, I <sub>G</sub> = 0, (see Note 3)			V <sub>D</sub> = -3 V	100	pF
				V <sub>D</sub> = -48 V	50	pF

NOTES: 3. These capacitance measurements employ a three terminal capacitance bridge incorporating a guard circuit. The unmeasured device terminals are a.c. connected to the guard terminal of the bridge.

## Thermal Characteristics

Parameter	Test Conditions	Min	Typ	Max	Unit
R <sub>θJA</sub> Junction to free air thermal resistance	T <sub>A</sub> = 25 °C, EIA/JESD51-3 PCB, EIA/JESD51-2 environment, P <sub>TOT</sub> = 1.7 W			120	°C/W

NOVEMBER 1995 - REVISED JULY 2008

Specifications are subject to change without notice.

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Parameter Measurement Information

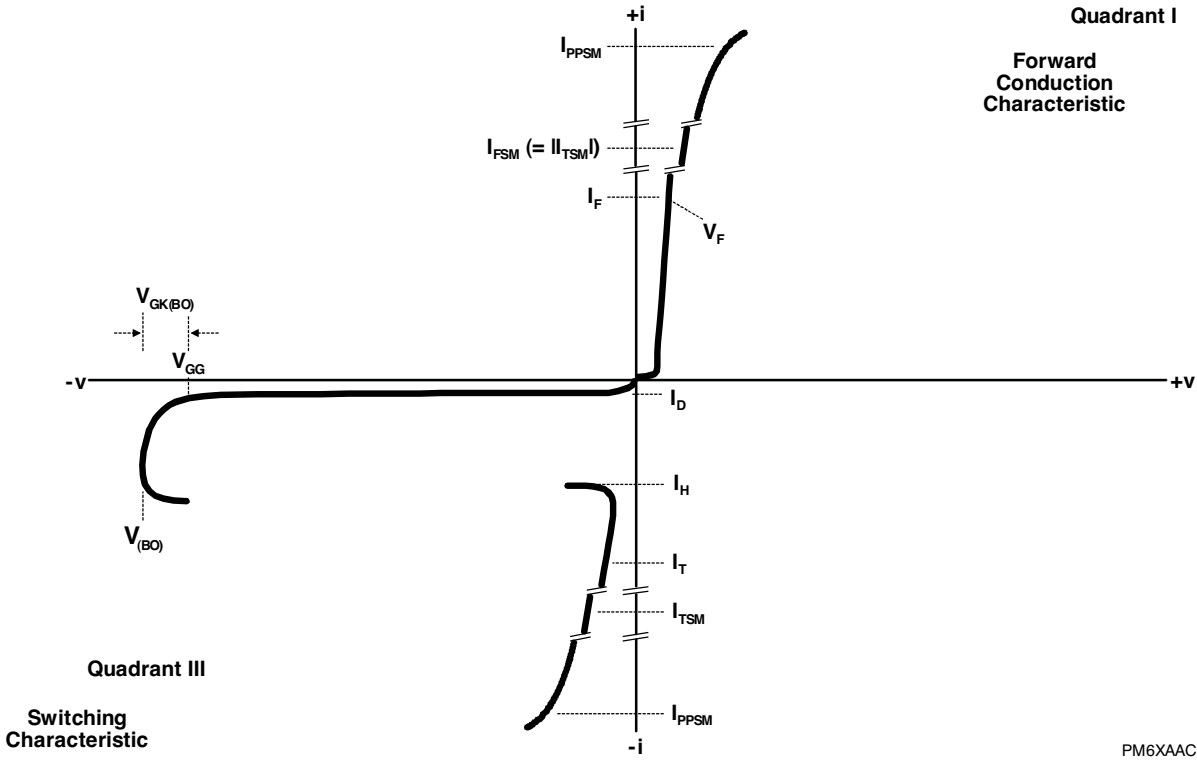
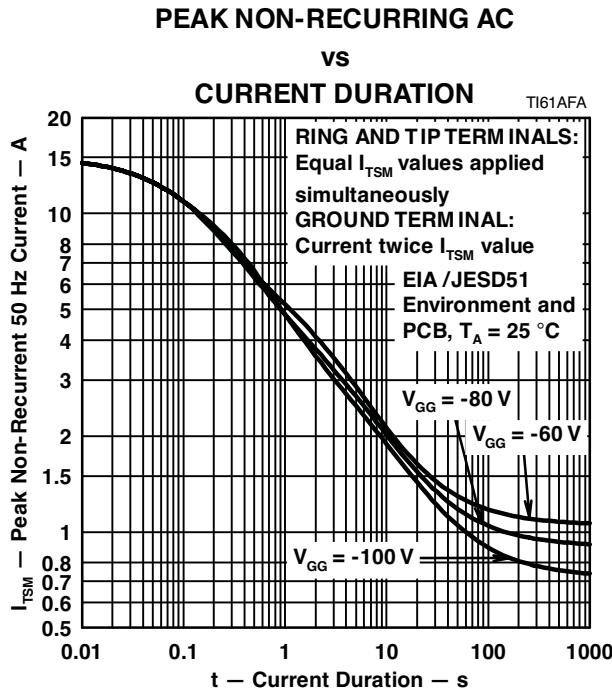


Figure 1. Voltage-Current Characteristic  
Unless Otherwise Noted, All Voltages are Referenced to the Anode

Thermal Information



**Figure 2. Non-repetitive Peak On-State Current against Duration**  
(Gate Voltage Ranges are -20 V to -75 V for the '61089 and -20 V to -100 V for the '61089A)

## APPLICATIONS INFORMATION

### Gated Protectors

This section covers three topics. First, it is explained why gated protectors are needed. Second, the voltage limiting action of the protector is described. Third, an example application circuit is described.

### Purpose of Gated Protectors

Fixed voltage thyristor overvoltage protectors have been used since the early 1980s to protect monolithic SLICs (Subscriber Line Interface Circuits) against overvoltages on the telephone line caused by lightning, a.c. power contact and induction. As the SLIC was usually powered from a fixed voltage negative supply rail, the limiting voltage of the protector could also be a fixed value. The TISP1072F3 is a typical example of a fixed voltage SLIC protector.

SLICs have become more sophisticated. To minimize power consumption, some designs automatically adjust the supply voltage,  $V_{BAT}$ , to a value that is just sufficient to drive the required line current. For short lines the supply voltage would be set low, but for long lines, a higher supply voltage would be generated to drive sufficient line current. The optimum protection for this type of SLIC would be given by a protection voltage which tracks the SLIC supply voltage. This can be achieved by connecting the protection thyristor gate to the SLIC supply, Figure 3. This gated (programmable) protection arrangement minimizes the voltage stress on the SLIC, no matter what value of supply voltage.

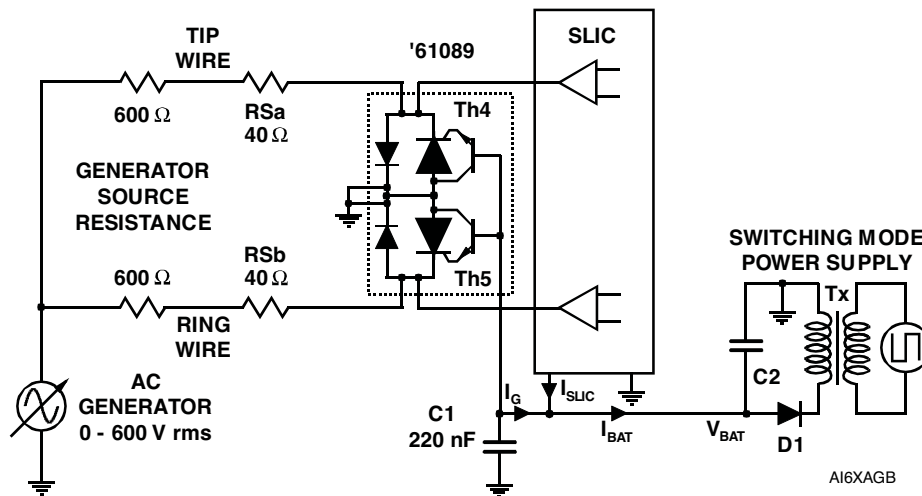


Figure 3. '61089 Buffered Gate Protector

### Operation of Gated Protectors

Figures 4 and 5 show how the '61089 device limits negative and positive overvoltages. Positive overvoltages (Figure 5) are clipped by the antiparallel diodes in the '61089 protector and the resulting current is diverted to ground. Negative overvoltages (Figure 4) are initially clipped close to the SLIC negative supply rail value ( $V_{BAT}$ ). If sufficient current is available from the overvoltage, then the protector (Th5) will crowbar into a low voltage on-state condition. As the overvoltage subsides the high holding current of the crowbar prevents d.c. latchup. The protection voltage will be the sum of the gate supply ( $V_{BAT}$ ) and the peak gate-cathode voltage ( $V_{GK(BO)}$ ). The protection voltage will be increased if there is a long connection between the gate decoupling capacitor, C1, and the gate terminal. During the initial rise of a fast impulse, the gate current ( $I_G$ ) is the same as the cathode current ( $I_K$ ). Rates of 70 A/ $\mu$ s can cause inductive voltages of 0.7 V in 2.5 cm of printed wiring track. To minimize this inductive voltage increase of protection voltage, the length of the capacitor to gate terminal tracking should be minimized. Inductive voltages in the protector cathode wiring will also increase the protection voltage. These voltages can be minimized by routing the SLIC connection through the protector as shown in Figure 3.

### Application Circuit

Figure 6 shows a typical '61089 part SLIC card protection circuit. The incoming line conductors, Ring (R) and Tip (T), connect to the relay matrix via the series overcurrent protection. Fusible resistors, fuses and positive temperature coefficient (PTC) thermistors can be used for overcurrent protection. Resistors will reduce the prospective current from the surge generator for both the '61089 device and the ring/test

## APPLICATIONS INFORMATION

### Application Circuit (Continued)

protector. The TISP7xxxF3 protector has the same protection voltage for any terminal pair. This protector is used when the ring generator configuration may be ground or battery-backed. For dedicated ground-backed ringing generators, the TISP3xxxF3 gives better protection as its inter-conductor protection voltage is twice the conductor to ground value.

Relay contacts 3a and 3b connect the line conductors to the SLIC via the '61089 protector. The protector gate reference voltage comes from the SLIC negative supply ( $V_{BAT}$ ). A 220 nF gate capacitor sources the high gate current pulses caused by fast rising impulses.

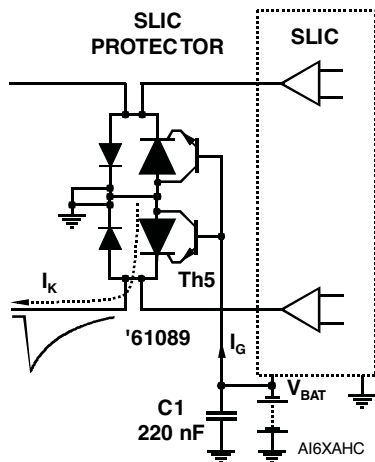


Figure 4. Negative Overvoltage Condition

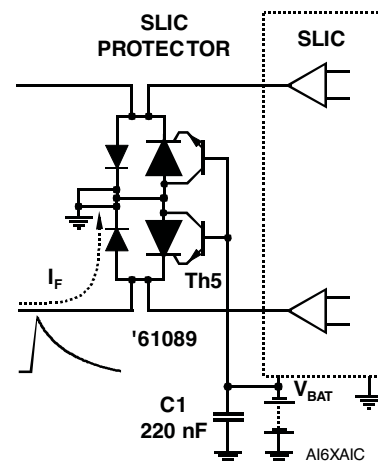


Figure 5. Positive Overvoltage Condition

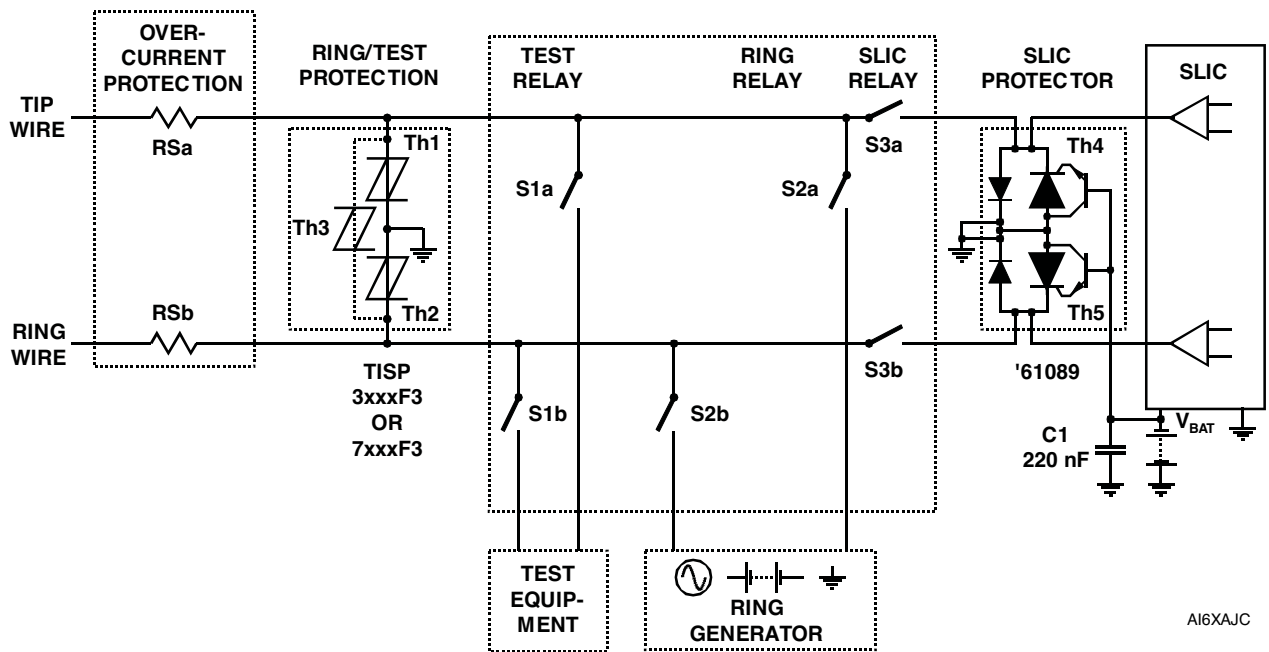


Figure 6. Typical Application Circuit



## MECHANICAL DATA

### Device Symbolization Code

Devices will be coded as below.

Device	Symbolization Code
TISP61089DR-S	P61089
TISP61089SDR-S	61089S
TISP61089ADR-S	61089A
TISP61089ASDR-S	1089AS